

Search Notes

Application/Control No.

10/604,671

Examiner

Christopher Verdier

Applicant(s)/Patent under
Reexamination

LIU ET AL.

Art Unit

3745

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|-------------------------------------|-----------|----------|
| 415 | 175-176, 178, 204, 206, 208.1 | 3/29/2006 | CV |
| 415 | 101-102 | 3/29/2006 | CV |
| 415 | 211.1 | 3/29/2006 | CV |
| 415 | 228 | 3/29/2006 | CV |
| 416 | 185, 186R | 3/29/2006 | CV |
| 416 | 187-188 | 3/29/2006 | CV |
| 416 | 223B, 238 | 3/29/2006 | CV |
| 416 | 242 | 3/29/2006 | CV |
| 62 | 180, 186 | 3/29/2006 | CV |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|------|----------|
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
|--|-----------|------|
| Consulted: Tanner - 62 | 3/29/2006 | CV |
| Inventor name search (EAST - USPAT, USPGPUB) - see attached search history | 3/29/2006 | CV |
| Inventor name search (PALM) - see attached search history | 3/29/2006 | CV |
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